Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
09265073	OVARD ET AL.
Examiner	Art Unit
Nam V Nguyen	2612

SEARCHED							
Class	Subclass	Date	Examiner				
340	10.4;	7/5/08	NN				
455	38.2; 106; 73	7/5/08	NN				

SEARCH NOTES				
Search Notes	Date	Examiner		
Search EAST: uspat; us-pub; epo; jpo and derwent (updated search).	7/5/08	NN		
Search Terms: interrogation with plurality of stations; rf circuitry for different ranges.	7/5/08	NN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

U.S. Patent and Trademark Office Part of Paper No.: 20080706